NST3906DXV6T1, NST3906DXV6T5

Dual General Purpose Transistor

The NST3906DXV6T1 device is a spin-off of our popular SOT-23/SOT-323 three-leaded device. It is designed for general purpose amplifier applications and is housed in the SOT-563 six-leaded surface mount package. By putting two discrete devices in one package, this device is ideal for low-power surface mount applications where board space is at a premium.

- h_{FE}, 100-300
- Low $V_{CE(sat)}$, ≤ 0.4 V
- Simplifies Circuit Design
- Reduces Board Space
- Reduces Component Count
- Lead-Free Solder Plating

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	-40	Vdc
Collector-Base Voltage	V_{CBO}	-40	Vdc
Emitter-Base Voltage	V_{EBO}	-5.0	Vdc
Collector Current - Continuous	I_C	-200	mAdc
Electrostatic Discharge	ESD	HBM>16000, MM>2000	V

THERMAL CHARACTERISTICS

Characteristic (One Junction Heated)	Symbol	Max	Unit
Total Device Dissipation $T_A = 25°C$ Derate above 25°C	P_D	357 (Note 1) 2.9 (Note 1)	mW mW/°C
Thermal Resistance Junction-to-Ambient	$R_{\theta JA}$	350 (Note 1)	°C/W

Characteristic (Both Junctions Heated)	Symbol	Max	Unit
Total Device Dissipation $T_A = 25°C$ Derate above 25°C	P_D	500 (Note 1) 4.0 (Note 1)	mW mW/°C
Thermal Resistance Junction-to-Ambient	$R_{\theta JA}$	250 (Note 1)	°C/W
Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to +150	°C

1. FR-4 @ Minimum Pad
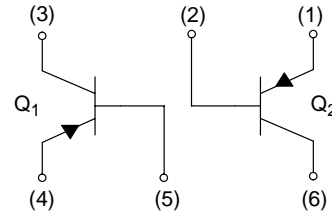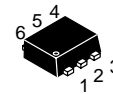
NST3906DXV6T1

SOT-563
CASE 463A
PLASTIC

MARKING DIAGRAM

A2 = Specific Device Code
D = Date Code

ORDERING INFORMATION

Device	Package	Shipping
NST3906DXV6T1	SOT-563	4 mm pitch 4000/Tape & Reel
NST3906DXV6T5	SOT-563	2 mm pitch 8000/Tape & Reel

March, 2003 - Rev. 0

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ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

| Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS				
Collector - Emitter Breakdown Voltage (Note 2)	$V_{(BR)CEO}$	-40	-	Vdc
Collector - Base Breakdown Voltage	$V_{(BR)CBO}$	-40	-	Vdc
Emitter - Base Breakdown Voltage	$V_{(BR)EBO}$	-5.0	-	Vdc
Base Cutoff Current	I_{BL}	-	-50	nAdc
Collector Cutoff Current	I_{CEX}	-	-50	nAdc
ON CHARACTERISTICS (Note 2)				
DC Current Gain (I_C = -0.1 mAdc, V_{CE} = -1.0 Vdc) (I_C = -1.0 mAdc, V_{CE} = -1.0 Vdc) (I_C = -10 mAdc, V_{CE} = -1.0 Vdc) (I_C = -50 mAdc, V_{CE} = -1.0 Vdc) (I_C = -100 mAdc, V_{CE} = -1.0 Vdc)	h_{FE}	 60 80 100 60 30	 - - 300 - -	-
Collector - Emitter Saturation Voltage (I_C = -10 mAdc, I_B = -1.0 mAdc) (I_C = -50 mAdc, I_B = -5.0 mAdc)	$V_{CE(sat)}$	 - -	 -0.25 -0.4	Vdc
Base - Emitter Saturation Voltage (I_C = -10 mAdc, I_B = -1.0 mAdc) (I_C = -50 mAdc, I_B = -5.0 mAdc)	$V_{BE(sat)}$	 -0.65 -	 -0.85 -0.95	Vdc
SMALL- SIGNAL CHARACTERISTICS				
Current - Gain - Bandwidth Product	f_T	250	-	MHz
Output Capacitance	C_{obo}	-	4.5	pF
Input Capacitance	C_{ibo}	-	10.0	pF
Input Impedance (V_{CE} = -10 Vdc, I_C = -1.0 mAdc, f = 1.0 kHz)	h_{ie}	2.0	12	k Ω
Voltage Feedback Ratio (V_{CE} = -10 Vdc, I_C = -1.0 mAdc, f = 1.0 kHz)	h_{re}	0.1	10	X 10^{-4}
Small - Signal Current Gain (V_{CE} = -10 Vdc, I_C = -1.0 mAdc, f = 1.0 kHz)	h_{fe}	100	400	-
Output Admittance (V_{CE} = -10 Vdc, I_C = -1.0 mAdc, f = 1.0 kHz)	h_{oe}	3.0	60	µmhos
Noise Figure (V_{CE} = -5.0 Vdc, I_C = -100 µAdc, R_S = 1.0 k Ω, f = 1.0 kHz)	NF	-	4.0	dB

SWITCHING CHARACTERISTICS

		Symbol	Min	Max	Unit
Delay Time	(V_{CC} = -3.0 Vdc, V_{BE} = 0.5 Vdc)	t_d	-	35	ns
Rise Time	(I_C = -10 mAdc, I_{B1} = -1.0 mAdc)	t_r	-	35	ns
Storage Time	(V_{CC} = -3.0 Vdc, I_C = -10 mAdc)	t_s	-	225	ns
Fall Time	(I_{B1} = I_{B2} = -1.0 mAdc)	t_f	-	75	ns

2. Pulse Test: Pulse Width ≤ 300 µs; Duty Cycle ≤ 2.0%.

NST3906DXV6T1, NST3906DXV6T5
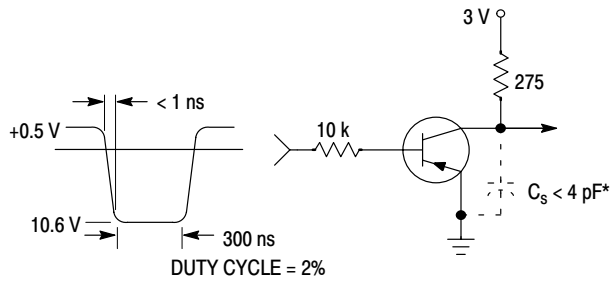
Figure 1. Delay and Rise Time
Equivalent Test Circuit
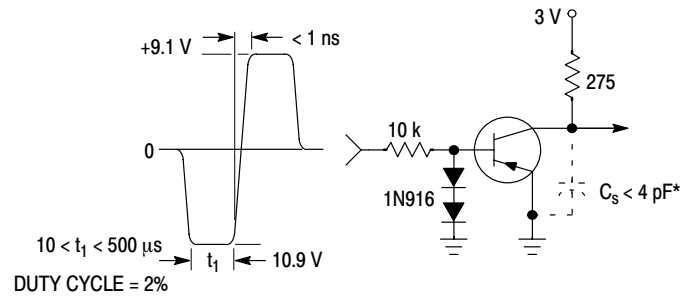
Figure 2. Storage and Fall Time
Equivalent Test Circuit

* Total shunt capacitance of test jig and connectors
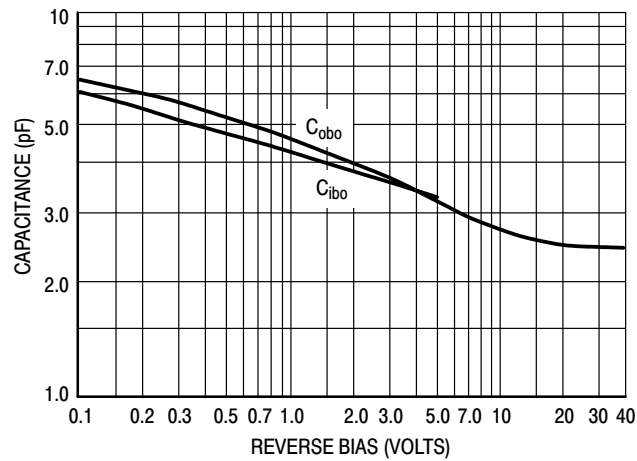
TYPICAL TRANSIENT CHARACTERISTICS
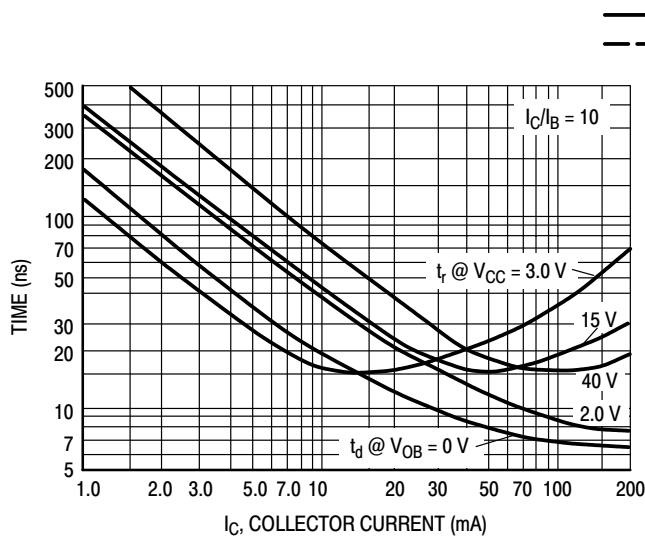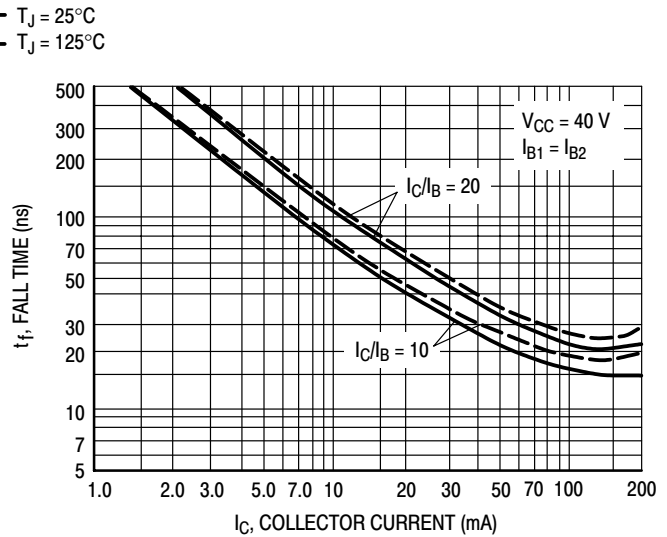

Figure 3. Capacitance

Figure 4. Turn-On Time

Figure 5. Fall Time

TYPICAL AUDIO SMALL-SIGNAL CHARACTERISTICS
NOISE FIGURE VARIATIONS
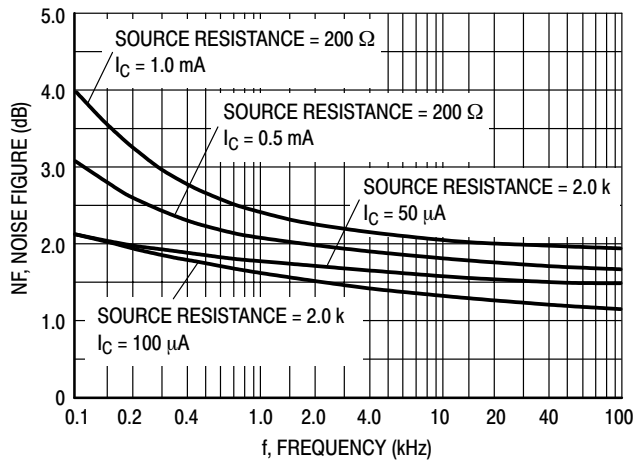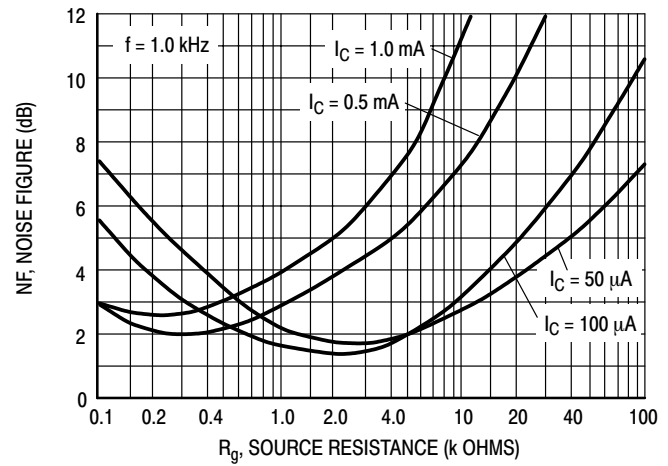(V_{CE} = -5.0 Vdc, T_A = 25°C, Bandwidth = 1.0 Hz)

Figure 6.

Figure 7.

h PARAMETERS
(V_{CE} = -10 Vdc, f = 1.0 kHz, T_A = 25°C)
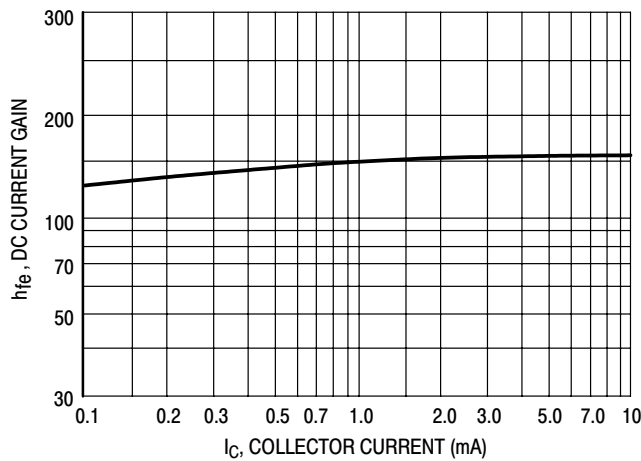
Figure 8. Current Gain
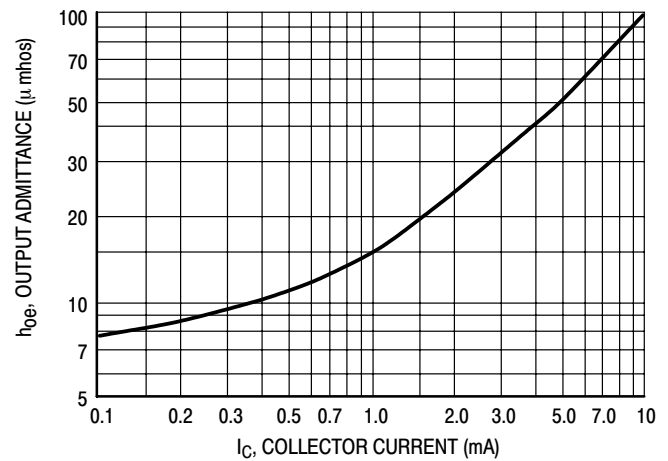
Figure 9. Output Admittance
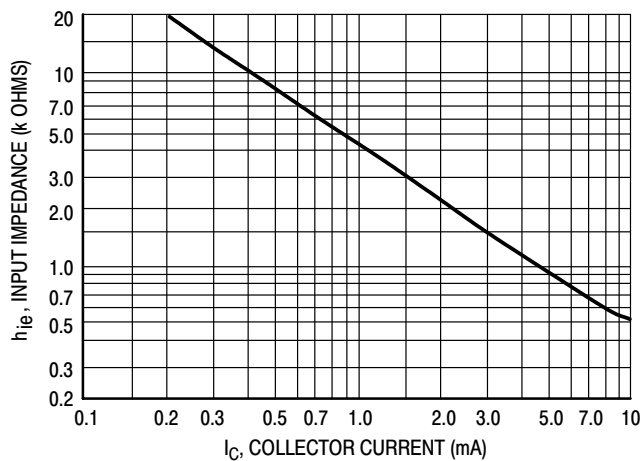
Figure 10. Input Impedance
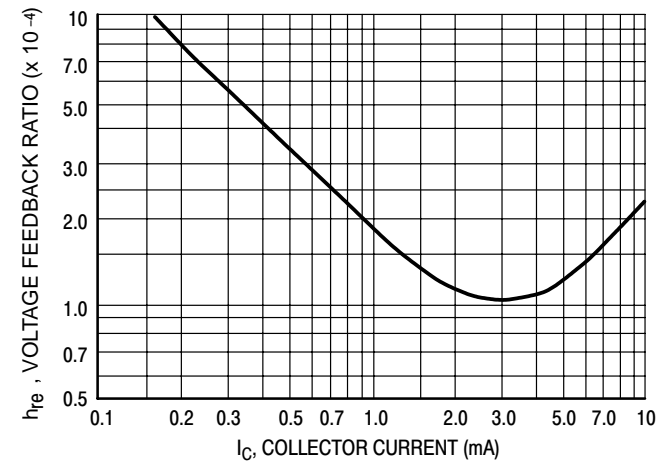
Figure 11. Voltage Feedback Ratio

NST3906DXV6T1, NST3906DXV6T5

TYPICAL STATIC CHARACTERISTICS
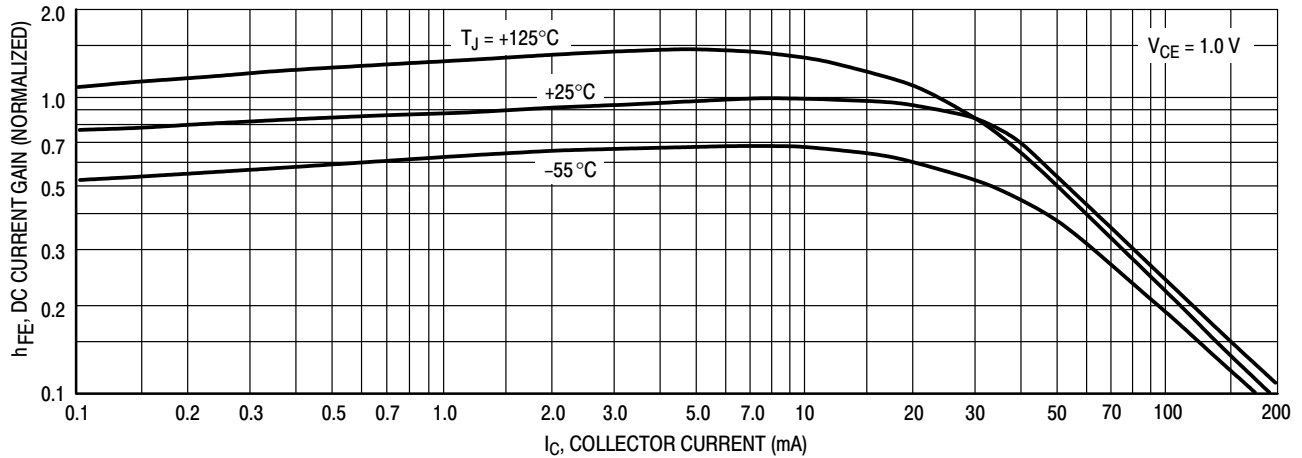
Figure 12. DC Current Gain
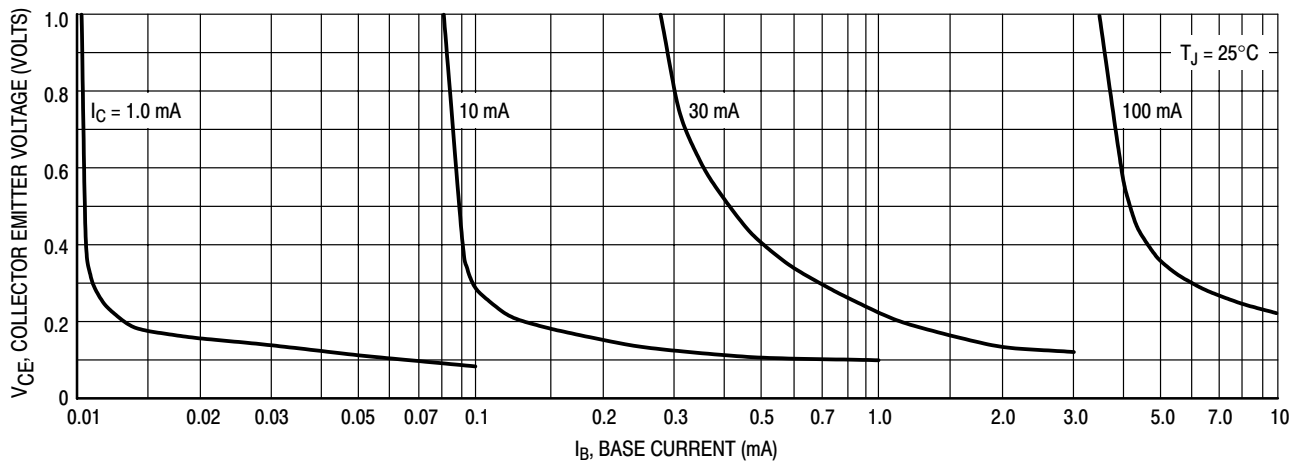
Figure 13. Collector Saturation Region
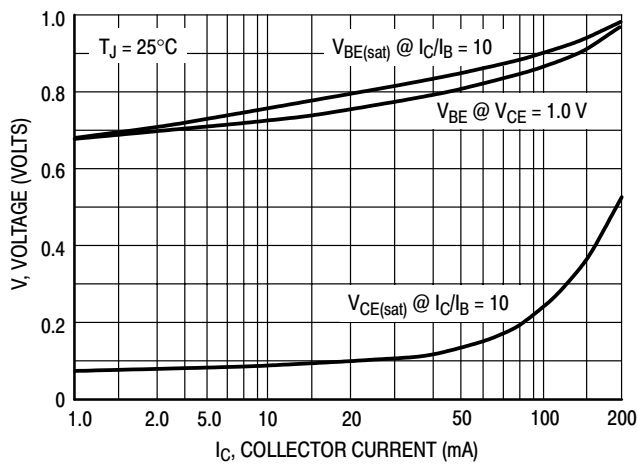

Figure 14. "ON" Voltages
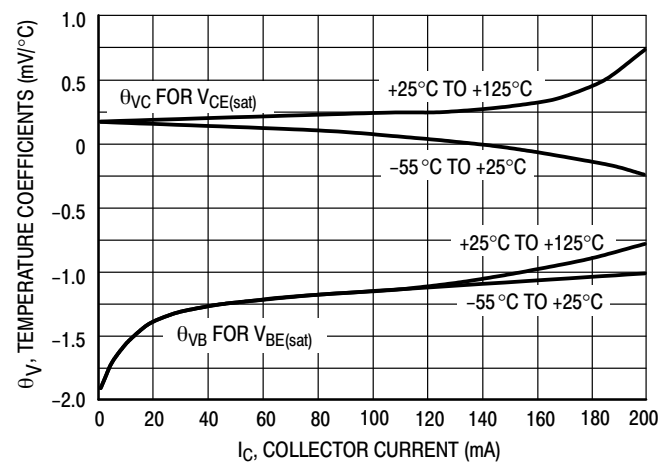
Figure 15. Temperature Coefficients

INFORMATION FOR USING THE SOT-563 SURFACE MOUNT PACKAGE

MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.

Dimensions in mm
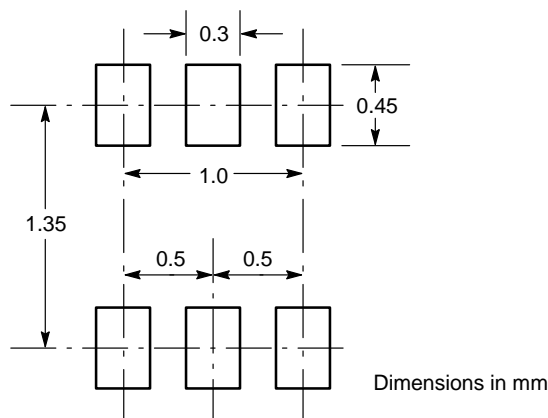
SOT-563

SOT-563 POWER DISSIPATION

The power dissipation of the SOT-563 is a function of the pad size. This can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating temperature, T_A. Using the values provided on the data sheet for the SOT-563 package, P_D can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T_A of 25°C, one can calculate the power dissipation of the device which in this case is 150 milliwatts.

$$P_D = \frac{150°C - 25°C}{833°C/W} = 150 \text{ milliwatts}$$

The 833°C/W for the SOT-563 package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 150 milliwatts. There are other alternatives to achieving higher power dissipation from the SOT-563 package. Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad®. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

Thermal Clad is a registered trademark of the Bergquist Company.

SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes. Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.

* Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

SOT−563−6 1.60x1.20x0.55, 0.50P
CASE 463A
ISSUE J

DATE 15 FEB 2024

NOTES:
1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5−2018.
2. ALL DIMENSION ARE IN MILLIMETERS.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
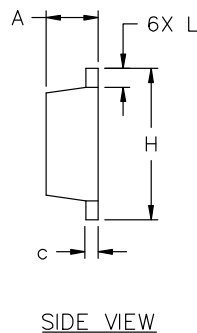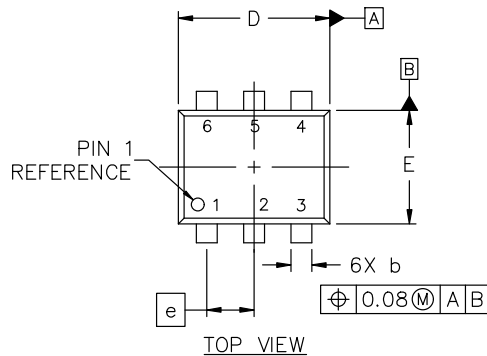
DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.50	0.55	0.60
b	0.17	0.22	0.27
c	0.08	0.13	0.18
D	1.50	1.60	1.70
E	1.10	1.20	1.30
e	0.50 BSC		
H	1.50	1.60	1.70
L	0.10	0.20	0.30

TOP VIEW

SIDE VIEW
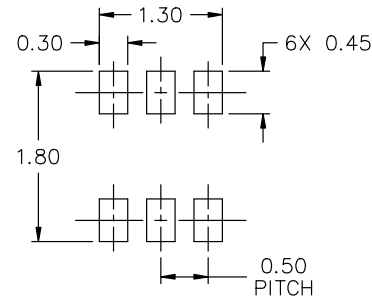
RECOMMENDED MOUNTING FOOTPRINT*

* FOR ADDITIONAL INFORMATION ON OUR Pb−FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

STYLE 1:
PIN 1. EMITTER 1
2. BASE 1
3. COLLECTOR 2
4. EMITTER 2
5. BASE 2
6. COLLECTOR 1

STYLE 2:
PIN 1. EMITTER 1
2. EMITTER 2
3. BASE 2
4. COLLECTOR 2
5. BASE 1
6. COLLECTOR 1

STYLE 3:
PIN 1. CATHODE 1
2. CATHODE 1
3. ANODE/ANODE 2
4. CATHODE 2
5. CATHODE 2
6. ANODE/ANODE 1

STYLE 4:
PIN 1. COLLECTOR
2. COLLECTOR
3. BASE
4. EMITTER
5. COLLECTOR
6. COLLECTOR

STYLE 5:
PIN 1. CATHODE
2. CATHODE
3. ANODE
4. ANODE
5. CATHODE
6. CATHODE

STYLE 6:
PIN 1. CATHODE
2. ANODE
3. CATHODE
4. CATHODE
5. CATHODE
6. CATHODE

STYLE 7:
PIN 1. CATHODE
2. ANODE
3. CATHODE
4. CATHODE
5. ANODE
6. CATHODE

STYLE 8:
PIN 1. DRAIN
2. DRAIN
3. GATE
4. SOURCE
5. DRAIN
6. DRAIN

STYLE 9:
PIN 1. SOURCE 1
2. GATE 1
3. DRAIN 2
4. SOURCE 2
5. GATE 2
6. DRAIN 1

STYLE 10:
PIN 1. CATHODE 1
2. N/C
3. CATHODE 2
4. ANODE 2
5. N/C
6. ANODE 1

STYLE 11:
PIN 1. EMITTER 2
2. BASE 2
3. COLLECTOR 1
4. EMITTER 1
5. BASE 1
6. COLLECTOR 2

GENERIC MARKING DIAGRAM*

XXM▪
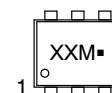
XX = Specific Device Code
M = Month Code
▪ = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	SOT−563−6 1.60x1.20x0.55, 0.50P		PAGE 1 OF 1

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:
Technical Library: www.onsemi.com/design/resources/technical–documentation
onsemi Website: www.onsemi.com

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For additional information, please contact your local Sales Representative at
www.onsemi.com/support/sales

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